


<b>Search Notes</b>  	<b>Application/Control No.</b>  10652327	<b>Applicant(s)/Patent Under Reexamination</b>  ELZUR ET AL.
	<b>Examiner</b>  Hoang, Hieu T	<b>Art Unit</b>  2152

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
709	229, 230, 250	9/12/2007	HH

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST	9/12/2007	HH
NPL (Google, IETF, IEEE)	9/12/2007	HH

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>